

X-Ray Diffraction

GeoFlex quantitative cuttings analysis and imaging service component

APPLICATION

Mineralogical quantification in all geological formations

BENEFITS

- Optimizes well placement
- Improves lithological description of cuttings
- Eliminates subjectivity in cuttings descriptions
- Enables well-to-well correlation
- Identifies formation tops

FEATURES

- Quantification of minerals common in sedimentary rocks
- Proprietary software for automatic and semiautomatic mineralogical quantification
- Direct data storage in Schlumberger acquisition system
- Real-time data transmission for near-real-time remote interpretation
- Compatibility with all drilling fluid types
- Main clays families identification (illite/muscovite, kaolinite, montmorillonite, and chlorite)
- Feldspars quantification: Plagioclase and K-feldspars

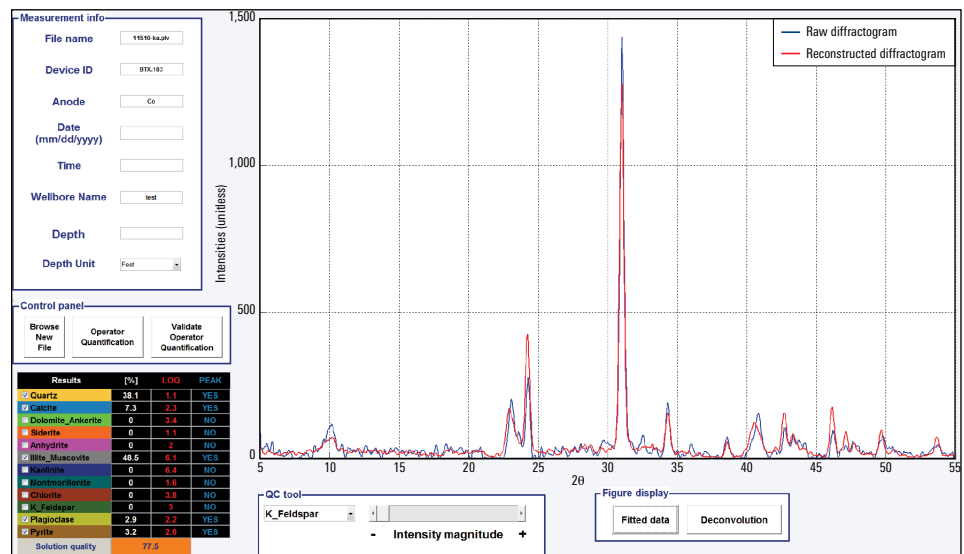
The GeoFlex* quantitative cuttings analysis and imaging service uses X-ray diffraction (XRD) to identify formation tops and complex lithologies in near-real-time at the wellsite. This quantitative approach identifies key mineralogical markers, improving the quality of lithological descriptions and eliminating subjectivity in cuttings descriptions.

Methodology

Measurements are performed on drilled cuttings that have been washed, dried, and crushed to a grain size of less than 150 ug. During analysis, light is scattered and diffracted by each crystal of the sample powder. Because every mineral has its own crystal shape, the scattered light produces a unique diffractogram pattern. The analysis of the obtained diffractogram is done automatically or semiautomatically by an analyst, who may be located onsite or offsite. From the analysis of the diffractogram, the various minerals are identified and their concentrations are quantified.

Quantification

In combination with Schlumberger proprietary software, the XRD device automatically identifies and quantifies minerals present in rock samples. The software uses specific algorithms based on a database of mineral diffraction patterns and proprietary calibration process for various type of rock mixtures and matrices. In one click, the software refines raw diffraction patterns and identifies and quantifies the most common minerals present in rock samples. This process increases data consistency, reproducibility and quality.



Automatic mineralogical quantification performed by proprietary software shows a close match between the raw and reconstructed diffractograms. This indicates that all minerals have been identified.

X-Ray Diffraction

Mineralogical Phases	Average Absolute Deviation, %	Limit of Quantification for K_{α} (Co) Radiation (Si-Rich Matrix), %	Limit of Quantification for K_{α} (Co) Radiation (Ca-Rich Matrix), %
Quartz	5	na	1
Calcite	4	2.3	na
Dolomite/ankerite	4	3.3	3.9
Siderite	7	0.6	1.1
Anhydrite	4	1.8	4.5
Total feldspars	4	na	na
Microcline (K-feldspars)	5	2.9	4.4
Albite (plagioclase)	3	2.1	3.2
Total clays and micas	4	na	na
Illite/muscovite	4	5.8	9.2
Kaolinite	5	6.2	7.8
Montmorillonite (smectite)	3	1.5	2.4
Chlorite	4	3.5	7.1
Pyrite	5	2.3	5.1

na = not applicable

Specifications

XRD range	5° to 55° 2 θ
Detector type	Two-dimensional Peltier-cooled charge-couple device (1,024 × 256 pixels)
X-ray target	Cobalt [†]
X-ray tube voltage	30,000 V
X-ray power tube	10 W
Operating temperature	14 to 95 degF [−10 to 35 degC]
Dimension	12 × 7 × 19 in [30 × 17 × 47 cm]
Weight	27.5 lbm [12.5 kg]
Geiger count	0 mSv

[†] Higher 2 θ spacing at low angle compared with standard copper tube allows improved visualization of clay mineral peak.
The service does not use a radioactive source for measurement.

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